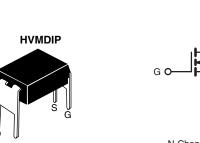


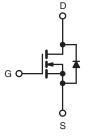
RoHS COMPLIANT



Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	0.8			
Q _g (Max.) (nC)	7				
Q _{gs} (nC)	2				
Q _{gd} (nC)	7				
Configuration	Single				





N-Channel MOSFET

FEATURES

- For Automatic Insertion
- Compact Plastic Package
- End Stackable
- Fast Switching
- Low Drive Current
- Easily Paralleled
- Excellent Temperature Stability
- Compliant to RoHS Directive 2002/95/EC

Note

Pb containing terminations are not RoHS compliant, exemptions may apply

DESCRIPTION

The HVMDIP technology is the key to Vishay's advanced line of power MOSFET transistors. The efficient geometry and unique processing of the HVMDIP design achieves very low on-state resistance combined with high transconductance and extreme device ruggedness. HVMDIPs feature all of the established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling, and temperature stability of the electrical parameters.

The HVMDIP 4 pin, dual-in-line package brings the advantages of HVMDIPs to high volume applications where automatic PC board insertion is desireable, such as circuit boards for computers, printers, telecommunications equipment, and consumer products. Their compatibility with automatic insertion equipment, low-profile and end stackable features represent the stat-of-the-art in power device packaging.

	ORDERING INFORMATION	
	Package	HVMDIP
I	Lead (Pb)-free	IRFD113PbF
		SiHFD113-E3

ABSOLUTE MAXIMUM RATINGS ($T_c = 25 \degree C$, unless otherwise noted)								
PARAMETER			SYMBOL	LIMIT	UNIT			
Drain-Source Voltage ^a			V _{DS}	60	V			
Gate-Source Voltage			V _{GS}	± 20	v			
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	Ι _D	0.8	^			
Pulsed Drain Current ^b			I _{DM}	6.4	A			
Linear Derating Factor				0.008	W/°C			
Inductive Current, Clamped	L = 1	00 μH	I _{LM}	6.4	A			
Maximum Power Dissipation	T _C = 25 °C		PD	1.0	W			
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C			
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^c	U			

Notes

a. T_J = 25 °C to 150 °C

b. Repetitive rating; pulse width limited by maximum junction temperature.

c. 1.6 mm from case.



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PARAMETER	SYMBOL	TYP. MAX. - 120			UNIT			
Maximum Junction-to-Ambient	R _{thJA}				°C/W			
		<u>.</u>						
SPECIFICATIONS (T _C = 25 °C, u	nless otherw	vise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	$V_{GS} = 0 V, I_D = 250 \mu A$			-	-	v
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$			2.0	-	4.0	v
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 500	nA
Zava Cata Valtaga Ducin Cumunt	1	V_{DS} = max. rating, V_{GS} = 0 V V_{DS} = max. rating x 0.8, V_{GS} = 0 V, T_C = 125 °C		-	-	250		
Zero Gate Voltage Drain Current	IDSS			-	-	1000	μA	
On-State Drain Current ^b	I _{D(on)}	$V_{GS} = 10 V$	$V_{DS} > I_{D(on)}$) x R _{DS(on)} max.	0.8	-	-	Α
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 10 V	I _D	= 0.8 A	-	0.6	0.8	Ω
Forward Transconductance ^b	g _{fs}	$V_{DS} > I_{D(on)} \times R_{DS(on)} \max., I_D = 0.8 \text{ A}$		0.8	1.2	-	S	
Dynamic		· · · ·						
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$			-	135	200	
Output Capacitance	C _{oss}	$V_{DS} = 25 V,$ f = 1.0 MHz		-	80	100	рF	
Reverse Transfer Capacitance	C _{rss}			-	20	25		
Total Gate Charge	Qg				-	5	7	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 V$	$I_D = 4 \text{ A},$ $V_{DS} = 0.8 \text{ max. rating}$		-	2	-	nC
Gate-Drain Charge	Q _{gd}		VDS - 0.	o max. rating	-	7	-	1
Turn-On Delay Time	t _{d(on)}		V _{DD} = 0.5 V _{DS} , I _D = 0.8 A,			10	20	
Rise Time	t _r	V _{DD} =				15	25	
Turn-Off Delay Time	t _{d(off)}	.00	$V_{DD} = 0.3 V_{DS}$, $T_D = 0.3 A$, $R_q = 50 \Omega$		-	15	25	ns
Fall Time	t _f				1	10	20	
Internal Drain Inductance	L _D	Between lead, 2 mm (0.08") from package and center of die contact		-	4.0	-		
Internal Source Inductance	Ls			-	6.0	-	nH	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	0.8		
Pulsed Diode Forward Current	I _{SM}			-	-	6.4	A	
Body Diode Voltage ^a	V _{SD}	$T_A = 25 \text{ °C}, I_S = 0.8 \text{ A}, V_{GS} = 0 \text{ V}$			-	-	2	V
Body Diode Reverse Recovery Time	t _{rr}	$- T_{\rm J} = 150 \text{ °C}, I_{\rm F} = 1.0 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}$		-	100	-	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.2	-	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is	negligible (turn-o	on is dom	inated by	/ L _S and L	_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

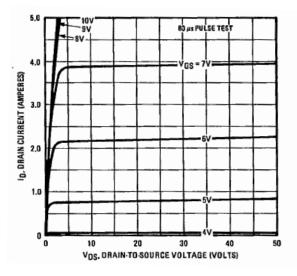


Fig. 1 - Typical Output Characteristics

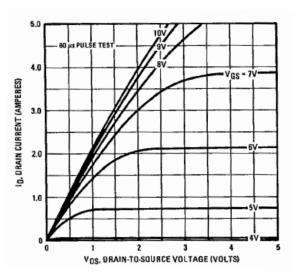


Fig. 3 - Typical Saturation Characteristics

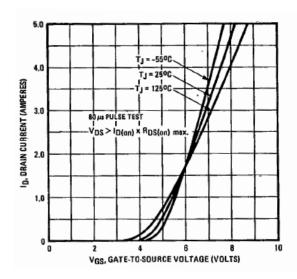


Fig. 2 - Typical Transfer Characteristics

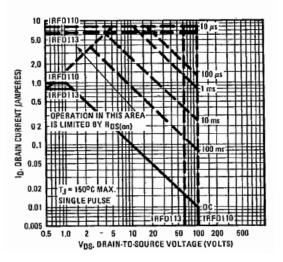


Fig. 4 - Maximum Safe Operatung Area



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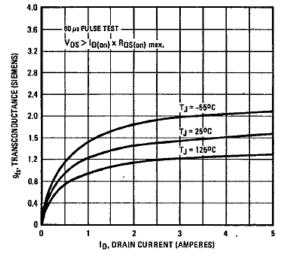


Fig. 5 - Typical Transconductance vs. Drain Current

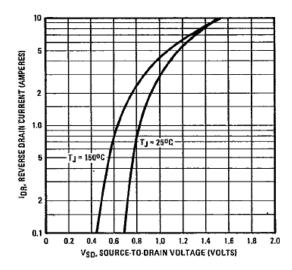


Fig. 6 - Typical Source-Drain Diode Forward Voltage

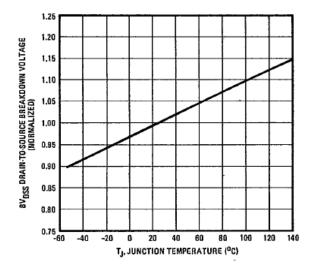


Fig. 7 - Breakdown Voltage vs. Temperature

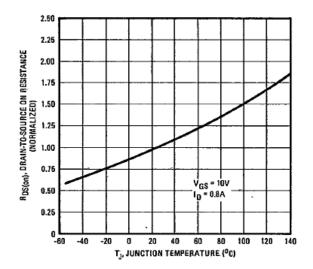


Fig. 8 - Normalized On-Resistance vs. Temperature



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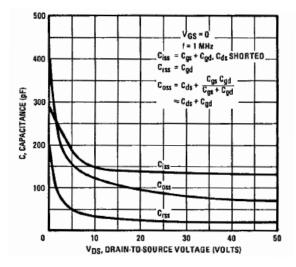


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

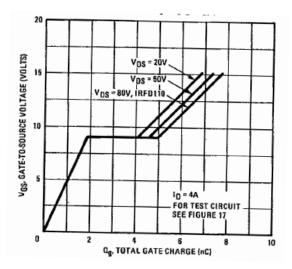


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

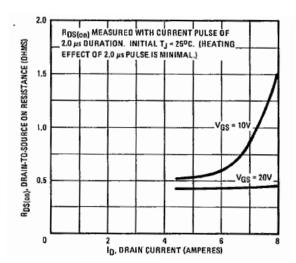


Fig. 11 - Typical On-Resistance vs. Darin Current

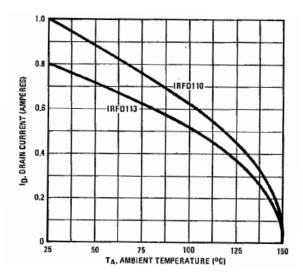
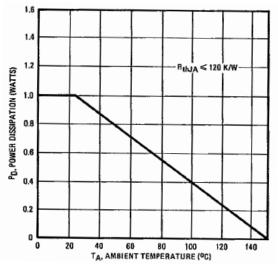


Fig. 12 - Maximum Darin Current vs. Case Temperature

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Fig. 13 - Power vs. Temperature Derating

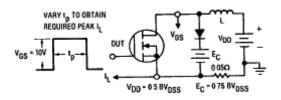


Fig. 14 - Clamped Inductive Test Circuit

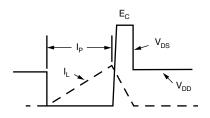


Fig. 15 - Clamped Inductive Waveforms

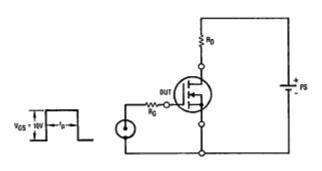


Fig. 16 - Switching Time Test Circuit

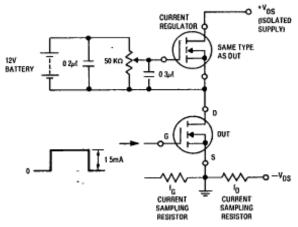
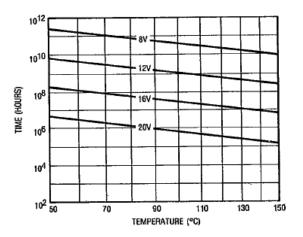


Fig. 17 - Gate Charge Test Circuit





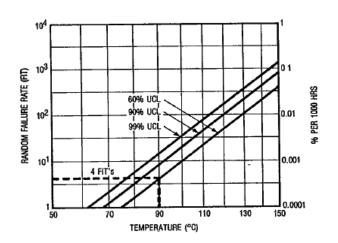
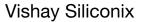


Fig. 19 - Typical High Temperature Reverse Bias (HTRB) Failure Rate

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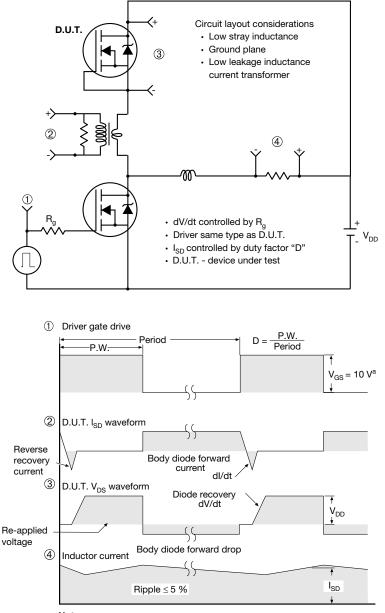
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Peak Diode Recovery dV/dt Test Circuit



Note

a. V_{GS} = 5 V for logic level devices

Fig. 20 - For N-Channel

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